Semiconductor Electrodes

XXXVII. Photoelectrochemical Behavior of p-Type Cu₂O in Acetonitrile Solutions

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ABSTRACT

The photoelectrochemical behavior of polycrystalline p-Cu₂O in acetonitrile solutions containing a number of redox couples [e.g., phthalonitrile (0/−1), nitrobenzene (0/−1), methyl viologen (+2/+1)] was investigated. The p-Cu₂O, grown by oxidation of Cu metal by thermal methods or anodization, showed stable behavior under optical irradiation in these solutions. The bandgap, estimated from photoacoustic spectroscopy (PAS) and the photocurrent action spectrum in solution, was ~2.0 eV and the flatband potential was ~ +0.16V vs. SCE. Scanning electron micrographs of the thermally grown samples reveal well-developed crystallites with distinct boundaries. A PEC cell of the form p-Cu₂O/Ph(CN)₂,MeCN/Pt was shown to have an overall optical-to-electrical energy conversion efficiency of only 0.05%. The low efficiency for such a cell is ascribed to rapid recombination processes in the bulk semiconductor and at the interface.

Cuprous oxide (Cu₂O), which crystallizes in a cuprite structure, is a catalyst of choice for a diverse variety of chemical reactions (1-4). The optical and electrical properties of p-Cu₂O depend upon the conditions of preparation from Cu and O₂, i.e., the temperature and oxygen pressure (5). Several workers (6-11) have studied the electrical properties of single crystals of this material and demonstrated that it is a p-type semiconductor whose hole conductivity can be attributed to copper ion vacancies which act as acceptors for electrons from the valence band. Recently, Trivich et al. (12) studied solid-state photovoltaic cells based on this material and reported an overall conversion efficiency of optical to electrical energy approaching 1% and stated that efficiencies of 6-12% should be possible. Aqueous photoelectrochemical (PEC) cells involving p-Cu₂O have also been described (13-14). In these cells the p-Cu₂O photocathode is unstable and under irradiation is reduced to Cu metal.

\[
\text{Cu}_2\text{O} + 2\text{H}^+ + 2e^- \rightarrow 2\text{Cu} + \text{H}_2\text{O} \quad [1]
\]

Similar instability was observed with CuO electrodes (15). In an aprotonic solvent such as acetonitrile (MeCN), however, such a reduction reaction is less favorable because of the unavailability of protons. Since the bandgap is 1.9-2.0 eV, and the reported efficiencies for photovoltaic devices appeared interesting and the material is inexpensive, abundant, and capable of being readily produced in thin film form, we undertook a study of the PEC properties of p-Cu₂O prepared by thermal and anodic oxidation of metallic copper in MeCN. The polycrystalline compacts were prepared by heating a Cu plate in air to minimize the grain boundary effects encountered in the case of sintered powder compacts (16). Studies of the PEC behavior of p-Cu₂O were carried out with MeCN containing several redox couples including phthalonitrile, Ph(CN)₂(0/−1), nitrobenzene, PhNO₂(0/−1), and methyl viologen MV (0/+2). Photocathodes of p-Cu₂O were shown to be stable in these solutions under intense optical irradiation. However, the overall optical-to-electrical energy conversion efficiencies in the PEC cells based on this material were low (< 0.1%).

Experimental

Chemicals.—The procedures for the purification of chemicals and solvent (MeCN) are given elsewhere (17). All compounds were stored inside a helium-filled Vacuum Atmosphere Corporation (Hawthorne, California) glove box. Polarographic grade, tetra-n-butyl ammonium perchlorate (TBAP), dissolved and recrystallized from ethanol thrice and dried under vacuum (< 10⁻¹⁰ Torr) for three days, was used as supporting electrolyte. The cell employed was a conventional two-compartment cell of 25 ml capacity containing the p-Cu₂O, a Pt counter electrode, and a quasi-reference electrode which was an Ag wire immersed in the solution and separated from the main compartment by a medium porosity glass frit. The potential of the electrode was checked against an aqueous saturated calomel electrode (SCE) at regular intervals and was found to be constant. All potentials reported here, unless specified otherwise, are given in V vs. SCE.

P-Cu₂O was prepared by the method of Trivich et al. (12, 18). A Cu plate, 0.8 mm thick (Alfa Ventron), was cut to a 2 x 2 cm square, polished with Al₂O₃ (0.5 µm), washed with acetone, and rinsed thoroughly with double distilled water. The plates were dried and heated in a muffle furnace at about 900°C for 24 hr. Subsequently, the furnace temperature was raised to 1050°C and the samples were heated for an additional 160 hr. The furnace temperature was then reduced to 500°C and at this temperature, the samples were annealed for a day, before quenching them in air at room temperature. Upon quenching, the CuO layer formed...
at the surface peels off, exposing the Cu₂O sintered compacts. The resistivity of the material after polishing with an ultrafine emery paper was ~ 30-40 Ω cm. An ohmic contact can be formed by either electropolishing the back with gold or partial reduction in an H₂ atmosphere at 100-125°C for 30 min. A copper wire lead formed the electrical contact and was attached to the gold-coated side with silver epoxy cement (Allied Product Corporation, New Haven, Connecticut). This contact was subsequently covered with 5 min epoxy cement. The assembly was mounted into 7 mm diam glass tubing and was held in position with a silicone rubber sealant (Dow Corning Corporation, Midland, Michigan), which also served as an effective seal against the seepage of electrolyte solution to the rear of the semiconductor electrode. The exposed area of p-Cu₂O was 0.14 cm². The etching procedures are given below. The material produced by the Cu-air reaction was shown to be Cu₂O by x-ray diffraction. The x-ray diffraction patterns corresponded to those reported in the literature (ASTM card Index No. 5.0667).

The p-Cu₂O films formed by anodic polarization of a Cu electrode were grown under either linear potential sweep or constant current conditions in aqueous NaOH solutions, mainly, following the procedures described by Marchiano et al. (19) and Ashworth and Fairhurst (20). The pretreatment of the Cu electrodes prior to oxidation described in the above papers was employed. Prepared N₂ was bubbled for 1 hr through the NaOH solutions, prior to and during the experiments, and an N₂ atmosphere was maintained over the solutions during the anodizations. The potential sweeps were performed at scan rates of 0.02, 0.2, or 1.0 mV/sec with the initial potential at -0.8 V (for 0.02 mV/sec) or -1.20 V (for 0.2 and 1.0 mV/sec) vs. SCE. The galvanostatic runs were performed at the current densities reported in Ref. (20).

Apparatus.—A Princeton Applied Research (PAR) Model 173 potentiostat and PAR Model 175 Universal programmer were used in all experiments with positive feedback r-compensation employed to compensate for solution resistance and internal resistance of the electrode. The i-V curves were recorded on a Model 2000 X-Y recorder (Houston Instruments, Austin, Texas). In solar cell experiments, the photovoltage and photocurrent between the working electrode and counter-electrode as a function of load resistance were measured with a Keithley Model 179, TRMS Digital Multimeter. The light source was an Oriel Corporation (Stamford, Connecticut) 450W xenon lamp. Differential capacitance was measured with a PAR Model HR 8 lock-in amplifier. All of these solutions were prepared in the glove box and the cell then sealed and removed for the experiments.

Etchants.—(A) For thermally grown p-Cu₂O, the following etchants were tried: (1) 12M HNO₃, (2) 6M HNO₃, (3) H₂SO₄:H₂O₂:H₂O; 3:1:1 (by volume), (4) HNO₃:H₃PO₄:acetic acid; 17:41.5:41.5 (by volume). In etchants (1), (2), and (3), the etching time was limited to 10-15 sec while for (4) the samples were kept immersed for 15 min. Procedure (1) exposed well-developed large Cu₂O-crystallites while (2) and (3) showed small Cu₂O crystallites. Procedure (4) produced a smooth and shiny surface. (B) The anodically produced films were etched with either (1) 0.01M or (2) 0.1M HNO₃ for 1-2 sec.

Results and Discussion

Capacitance measurements.—The location of the energies corresponding to the edges of the valence and the conduction bands, E₀ and Eₐ, respectively, of the semiconductor electrode with respect to solution energy levels, is useful in the selection of appropriate redox couples for optimizing PEC cell performance. These are usually found by determination of the flatband potential, Vₕb, by measurement of the electrode capacitance as a function of applied potential. If this capacitance corresponds to the semiconductor space-charge capacitance, Vₕb and the acceptor density (Nₐ) can be computed from Mott-Schottky plots (21-23). From these values, the known or estimated effective mass of charge carrier and the bandgap, the band positions (i.e., E₀ and Eₐ) can be located.

A dielectric constant of 7.11 (24) and an effective mass of charge carriers 0.84m₀ (25) was employed. The bandgap was measured by two methods which are described in the next section; the value determined from the photocurrent action spectrum was employed in the location of the bandedge. The capacitance of p-Cu₂O was measured in MeCN containing TBAP as supporting electrolyte at different frequencies from 100 to 5000 Hz; Mott-Schottky plots are given in Fig. 1. The Vₕb value determined at low frequencies (100 and 500 Hz) was located ~ 20 mV positive of that at high frequencies (2 and 5 kHz). Hence, an average value was taken for computation. These plots were essentially the same after repeated experiments over several hours and were unaffected by the addition of the reducible compound phthalonitrile to the solution. From these plots we estimate Vₕb as + 0.16 V vs. SCE and Nₐ = 4.9 × 10¹⁶ cm⁻².

Bandgap.—The bandgap energy, Eₔ, of p-Cu₂O was determined by two independent methods: From the photoacoustic spectrum of the sample in air (26) and from the photocurrent action spectrum in MeCN/ TBAP, Ph(CN)₉. The results of these experiments are shown in Fig. 2(a) and (b). Note that a plot of (ηhv)² vs. hv gives a straight line, suggesting that the optical transition in Cu₂O is direct and yields an Eₔ of 2.00 eV. The photoacoustic spectrum signals an onset of light absorption at 630 nm, corresponding to an Eₔ = 1.94 eV. The bandedge energies were obtained by assuming the Fermi-Dirac equation

\[ N_A = N_v [1 + 2e^{(E_v - E_F)/kT}]^{-1} \]  \[ N_v = 2(2\pi m^*kT/h^2)^{3/2} \]

Fig. 1. Mott-Schottky plot of p-Cu₂O, in MeCN containing 0.1M TBAP supporting electrolyte. ○ = 100 Hz; □ = 500 Hz; △ = 2000 Hz and ○ = 5000 Hz.
Fig. 2a. Plot of $h\nu$ vs. $(n\hbar \nu)^{1/2}$ where $n = 1$ and 4. The value of $\eta$ at different wavelengths has been computed from photocurrent action spectrum for p-Cu$_2$O in MeCN/0.1M TBAP, 10 mM Ph(CN)$_2$O/-2/Pt solar cell.

Fig. 2b. Absorption spectrum of p-Cu$_2$O (photoacoustic technique) (curve 2). Corrected action spectrum of the short-circuit photocurrent of p-Cu$_2$O (curve 1). Curve 3, background action spectrum of the 2.5 kW xenon lamp.

where $N_v$ is the density of states in the valence band; $E_F$ is the Fermi level energy (corresponding to $V_{FB}$); and $m_0^*$ is the effective mass of holes. This yielded the position of the VB edge about 0.1 eV below the Fermi level, i.e., at $+ 0.26$ V vs. SCE. From the value of $E_g$, 2.0 eV, $E_F$ is placed at $- 1.74$ V vs. SCE. These levels are shown in Fig. 3, along with the potentials for the solution redox couples employed in this study.

Cyclic voltammetry.—To study the photoinduced electron transfer to reducible molecules in solution, the cyclic voltammetric (CV) response at p-Cu$_2$O in the dark and under illumination was compared to that observed for these systems at a platinum electrode. At platinum, near-reversible CV behavior is observed, so that the redox potential of the couple can be obtained. The procedures and interpretations generally followed previous studies from this laboratory (17, 27-29).

The range of stability for the electrode in the absence of an added redox couple was determined from the CV behavior of p-Cu$_2$O in MeCN containing TBAP alone, as shown in Fig. 4(a). The dark current was very small up to $- 1.8$ V vs. SCE. Under illumination, no photocurrent was observed up to $- 1.5$ V. However, at more negative potentials a small and unstable photoinduced cathodic current was found, which probably involves reduction of the Cu$_2$O electrode perhaps involving trace impurities (e.g., H$_2$O) in the solvent.

The addition of a reducible substance to the MeCN/TBAP solution generally did not produce an appreciable increase in the dark cathodic current for potentials up to $- 1.60$ V, demonstrating the expected absence of dark electron transfer to solution species at the p-type semiconductor/liquid interface. Under illumination, however, the photogenerated electrons at energies corresponding to the conduction band edge can transfer to solution species, and significant photocathodic currents are produced. For example, the CV reduction of phthalonitrile [Ph(CN)$_2$] on Pt, given in Fig. 4(b), shows a reversible wave for the reduction to the radical anion at $- 1.72$ V vs. SCE. On p-Cu$_2$O, only a small dark reduction current is seen (Fig. 4c).

However, under illumination, significant cathodic current flows with the onset at potentials more positive than those for reduction at Pt (Fig. 4d). Note, how-
cathodic photocurrent rises rather slowly with potential and only attains a limiting value at \( \approx -0.9 \) V. This potential is for the start of the reduction of Ph(CN)\(_2\), the anodic current begins at \( \approx -0.6 \) V. Thus the onset of photocurrent occurs near the flatband potential. The presence of surface recombination or back-reaction below \(-0.5\) V vs. SCE is also demonstrated by the transient photocurrent vs. time behavior of p-Cu\(_2\)O in MeCN containing TBAP, Ph(CN)\(_2\)\(_{-1}\) (Fig. 4g). Upon illumination, the cathodic current shows a sharp increase, but then rapidly drops off as radical anion accumulates at the electrode surface. When the light is turned off, the current drops and an anodic current spike appears, representing oxidation of radical anion. At more negative potentials (e.g., \(-0.9\) V), only a flat photocathodic current transient appears, with no anodic dark transient. After continuous illumination for 6 hr, with the p-Cu\(_2\)O electrode held at \(-0.3\) V vs. SCE, the CV behavior was essentially unchanged (Fig. 4i), thus demonstrating the stability of the semiconductor electrode. The behavior of p-Cu\(_2\)O with Ph(CN)\(_2\) was typical of that found with other redox couples. From the location of the energy levels of these couples with respect to the band-edges (Fig. 3), one would predict, based on the “ideal” model of the semiconductor/liquid interface, that all of the couples would be photoreduced with the potential of the onset of photocurrent \( V_{\text{on}} \), located near \( V_{\text{FB}} \). This was found to be the case for solutions containing only the oxidized form of the couple. The values of \( V_{\text{on}} \) and \( V_{\text{redox}} \) are given in Table I. In all cases appreciable photocurrent flowed only at potentials significantly more negative than \( V_{\text{on}} \). The limiting quantum efficiency for the photogeneration of Ph(CN)\(_2\)\(^{-}\), defined as the ratio of the current (in electrons/s\( \cdot \)cm\(^2\)) to the absorbed light flux (in photons/s\( \cdot \)cm\(^2\)), with the p-Cu\(_2\)O electrode held at a potential of \(-1.0\) V where the limiting current is attained, was estimated at 500 nm. This value of \( \lambda \) corresponds to an energy greater than the bandgap of p-Cu\(_2\)O. The 500 nm radiation was obtained by interposing a Jarrel-Ash Company (U.S.A.) monochromator between the PEC cell and the xenon lamp (2500 W operated at 1600 W); the monochromatic light was focused on the p-Cu\(_2\)O electrode. The photocurrent was recorded on a Model 2000 X-Y recorder (Houston Instruments, Austin, Texas), was 0.70 \( \mu \)A/cm\(^2\). The PEC cell was then replaced and the monochromatic light intensity, measured by a radiometer/photometer, Model 550-1 (Electro Optics Division) was 14.6 \( \text{mW/cm}^2\). These values yield a monochromatic quantum efficiency of \( \sim 10.5\% \).

Effect of pretreatment.—The nature of the electrode surface pretreatment, e.g., via etching, is known to affect the behavior and PEC performance of SC electrodes (30, 31). Four different etchants were used in this work, described in the experimental section. Electrodes treated with etchants (2), (3), or (4) gave large dark currents as compared to those with 1 (12M)

"underpotential" for the start of the reduction of Ph(CN)\(_2\), the cathodic photocurrent rises rather slowly with potential and only attains a limiting value at \(-0.9\) V. This slow rise in cathodic photocurrent can be attributed to oxidation of the photogenerated reduced species, Ph(CN)\(_2\)\(^{-}\), at potentials between the onset potential and the limiting one. This oxidation of the reduced form is apparent from the reverse scan (Fig. 4e), where the current crosses the zero current axis at more negative potentials than the original onset potential and the presence of photogenerated radical anion, Ph(CN)\(_2\)\(^{-}\) causes an anodic current flow. Similarly, if the initial scan is carried out with a solution that contains both parent and radical anion, the onset potential occurs at more negative values, \(-0.6\) V vs. SCE (Fig. 4f). Moreover, as the concentration of radical anion is increased, the onset potential also shifts toward more negative values. In Fig. 4g is shown the effect of radical anion on the behavior of p-Cu\(_2\)O in dark. The dark oxidation current begins at \(-0.6\) V. Thus the back-

Table I. Voltammetric data and onset potential of photocurrent

| Redox couple | \( V_{\text{redox}} \) vs. SCE | \( V_{\text{on}} \) vs. SCE | \( N_A \) | \( V_{\text{PEC}} \) = \( | V_{\text{redox}} - V_{\text{on}} | \) |
|-------------|----------------|----------------|---------|----------------|
| Ph(CN)\(_2\)\(^{-}\) | -1.72 | +0.02 | 1.74 |
| Ph(NO\(_3\))\(^{-}\) | -1.13 | +0.03 | 1.16 |
| AB = azobenzene | -1.28 | +0.04 | 1.32 |
| AQ = anthraquinone | -0.96 | +0.04 | 1.00 |
| BQ = benzquinone | -0.36 | +0.06 | 0.92 |
| MV = methylviolegen | -0.43 | 0.00 | 0.43 |

* Abbreviations: Ph(CN)\(_2\) = phthaldimine; Ph(NO\(_3\)) = nitrobenzene; AB = azobenzene; AQ = anthraquinone; BQ = benzquinone; MV = methylviolegen.
\( \text{HNO}_3 \) (Fig. 5). Generally, electrodes that showed surfaces with large crystallites and grain boundaries, as produced by etching with 12M \( \text{HNO}_3 \), showed a better PEC performance than those with smooth and shiny surfaces [e.g., as produced by etchant (4)].

Anodically grown CuO films.—The PEC behavior of p-CuO anodic films depended upon the electrochemical conditions employed for growing the oxide film and the pretreatment of the Cu electrode before film formation. The films produced in aqueous NaOH solutions by linearly scanning the potential showed better photocurrent than those prepared by galvanostatic oxidation. Among the Cu electrode pretreatments tried [etching with 6M \( \text{HNO}_3 \), etching with FeCl_3 in EtOH, electropolishing (20)], or electropolishing with etching in FeCl_3], etching with HNO_3 produced electrodes which showed the largest photoeffects. Etching, with either FeCl_3 or the electropolished surfaces, yielded CuO films which showed a poor photocurrent. For films grown by linear scans, the photocurrent depended upon the potential scan rate, \( \nu \), for film growth. Films grown at very small \( \nu \) (0.02 mV/sec) exhibited better PEC behavior than those grown at higher scan rates (0.2 and 1.0 mV/sec). In the linear scan experiments, the formation of CuO was characterized by a peak obtained at \(-0.4 \) to \(-0.5\) V vs. SCE. Current-potential curves in the dark and under chopped illumination for p-CuO films (grown at 0.02 mV/sec in 1M and 5M NaOH) in MeCN/TBAP containing Ph(CN)_2 are given in Fig. 6. The photocurrent was clearly much greater for films grown in 5M NaOH. The beneficial effect of slow scan rate and higher NaOH concentration is probably caused by the formation of a less random and thicker film (20). Some improvement in the onset potential and photocurrent was achieved by etching the anodic CuO film with 0.01M HNO_3 for 1-2 sec. Etching with a more concentrated HNO_3 solution (0.1M) destroyed the photocurrent, presumably because dissolution of the CuO film occurred. Films grown in 10M NaOH gave a photocurrent similar to those grown in 5M NaOH at 0.02 mV/sec. Generally, however, the photocurrents at the anodic films were much smaller than those produced by the thermally grown material for similar solution and illumination conditions.

p-CuO/MeCN PEC cells.—The CV behavior can be used as a guide for the construction of PEC photovoltaic cells, where the open-circuit potential of the semiconductor ideally (in the absence of recombination) approaches \( V_{FB} \) and the metal counterelectrode is at \( V_{Yredox} \). Although the photocurrents found in the CV experiments with p-CuO were rather small, the behavior of actual two-electrode photovoltaic cells is of interest because observed response under these conditions is due to the effects seen are not merely caused by conductivity changes under illumination and allow an estimation of the actual power conversion efficiency of such devices. From the energy level diagram (Fig. 3) and the voltammetric measurements (Table I), cells containing Ph(CN)_2 would be expected to show the highest open-circuit voltage, \( V_{oc} \), and the best performance. The following cell was constructed: p-CuO/MeCN, TBAP (0.1M), Ph(CN)_2 (10 mM), Ph(CN)_2 (0.1 mM)/Pt. The p-CuO photocathode (0.14 cm²) and the Pt gauze (40 cm²) counterelectrode were spaced about 1.0 cm, with the p-CuO electrode about <0.1 cm from the cell window. The i-V characteristic of such a cell, obtained with different load resistances, is shown in Fig. 7. The open-circuit photocell was 0.3V, the short-circuit photocurrent density was 0.4 mA/cm², and the fill factor was 0.51. Note that this open-circuit voltage is considerably lower than the value predicted from voltammetric measurements conducted with solutions in the absence of appreciable Ph(CN)_2. It is, however, about the same as that found with solid-state p-CuO cells (12). From the

Fig. 5. Current-potential characteristics under chopped light on p-CuO in MeCN containing 0.2M PhNO_2, 0.1M TBAP. Solution (supporting electrolyte). Light source, 450W xenon lamp. Scan rate, 50 mV/sec. (a) p-CuO treated with 12M HNO_3; (b) p-CuO treated with 6M HNO_3; (c) p-CuO treated with \( \text{H}_2\text{SO}_4\); \( \text{H}_2\text{O}_2;\text{H}_2\text{O} = 3:1:1 \); (d) p-CuO treated with \( \text{HNO}_3\); \( \text{H}_2\text{PO}_4\); acetic acid = 17:41.5:4.15.

Fig. 6. Current-potential characteristics under chopped light on p-CuO (anodically oxidized) in MeCN containing 10 mM PhCN_2, 0.1M TBAP. Solution (supporting electrolyte). Light source, 450W xenon lamp. Scan rate, 50 mV/sec. (a) p-CuO prepared in 1M NaOH; (b) p-CuO prepared in 5M NaOH. a' and b' are in the dark.
losses, was calculated to be ~0.05%. This low value can probably be attributed to rapid recombination processes both within the bulk p-Cu$_2$O and at the interface. The currents were not limited by mass transfer and were unaffected by stirring. The Ph(CN)$_2^-$ was intentionally kept at a low concentration to decrease the light adsorption by this intensely colored species and to minimize the back-reaction at the p-Cu$_2$O surface. The photocurrent as a function of time is shown in Fig. 8. The photocurrent was fairly stable for at least 6 hr at which time the experiment was terminated.

Scanning electron micrographs of different thermally grown specimens after etching or polishing are given in Fig. 9. Samples etched with HNO$_3$ (Fig. 9a) showed the surfaces either polished with Al$_2$O$_3$ (0.5 μm) or etched with HNO$_3$: acetic acid: H$_2$PO$_4$ were smooth (Fig. 9c, d). To test if the small crystallites and numerous grain boundaries found with the 12M HNO$_3$ etched samples were responsible for the low photovoltages and efficiencies, an electrode was prepared in which all of the small crystallites were covered with silicone rubber sealant, leaving only a single large crystal exposed to the solution. However, PEC measurements with this electrode showed no apparent increase in either the photovoltage or photocurrent density. This suggests that there may be inherent problems in the efficiency of p-Cu$_2$O itself, and that marked improvement in the efficiency with this material may be difficult.

Conclusions

The p-Cu$_2$O photocathode is stable in MeCN containing a number of different redox couples under irradiation. The photopotential, $V_{ph}$, equal to $(V_{redox} - V_{sc})$, increases linearly with $V_{redox}$, with a slope near one. The onset of photocurrent is located, for all couples investigated, near the flatband. Pretreatment of the electrode plays an important role on the PEC performance of p-Cu$_2$O, and etching with 12M HNO$_3$ was found to give a reasonable photocurrent and small dark cathodic current. The 12M HNO$_3$ etched surface, which looks matte and polycrystalline with distinct grain boundaries, exhibited better PEC behavior than the one which was shiny and smooth (e.g., produced by an HNO$_3$: acetic acid:H$_2$PO$_4$ etching).

The overall conversion efficiency of optical-to-electrical energy for the PEC photovoltaic cells was low, < 0.1%. A brief comparison of the liquid junction photovoltaic cells with the solid-state cells is in order. Under similar irradiation intensities, the Schottky barrier Cu/p-Cu$_2$O cells under the best conditions are reported to show an efficiency of 0.8% (12). The observed open-circuit photovoltage (0.30V) and fill factor (0.39) are comparable to the values in the liquid junction cells, so that the lower efficiency can be traced to lower short-circuit photocurrents. Indeed, even in the solid-state cells, encapsulation of the cell with epoxy is required for optimum performance. This encapsulation not only reduces reflection losses but also decreased the observed dark current. Moreover, the resistivity of our p-Cu$_2$O was ~3-4 times that of the Cu$_2$O used in the solid-state cells and, in the absence of more promising efficiencies, we did not find it worthwhile to attempt to optimize the semiconductor material. In general, the low photocurrents and efficiencies in the liquid junction cells probably can be attributed to rapid surface and bulk recombination of the photogenerated charge carriers. On the basis of these results and the fact that efficiencies > 1% have not been reported for solid-state cells, unless a significant improvement in the materials, characteristics, and efficiency can be obtained, p-Cu$_2$O does not seem to be a promising candidate for PEC solar energy conversion devices.

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